

Notice of References Cited	Application/Control 10/011,022	Applicant(s)/Patent Under Reexamination VANDERSLUIS, KIRSTAN AND	
	Examiner David Y Jung	Art Unit 2134	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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NON-PATENT DOCUMENTS

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	U	www.heise.de./ix.artikel/E/1997/06/106
	V	hyper.sunjapan.com/cn/~hz/win32/styles3
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